R adiation-induced m agnetotransport in high-m obility two-dim ensional system s: R ole of electron heating

X L. Lei and S.Y. Liu

Department of Physics, Shanghai Jiaotong University, 1954 Huashan Road, Shanghai 200030, China

E ects of m icrow ave radiation on m agnetoresistance are analyzed in a balance-equation scheme that covers regimes of inter- and intra-Landau level processes and takes account of photon-asissted electron transitions as well as radiation-induced change of the electron distribution for high mobility two-dimensional systems. Short-range scatterings due to background impurities and defects are shown to be the dominant direct contributors to the photoresistance oscillations. The electron temperature characterizing the system heating due to irradiation, is derived by balancing the energy absorption from the radiation eld and the energy dissipation to the lattice through realistic electron-phonon couplings, exhibiting resonant oscillation. M icrow ave m odulations of Shubnikov de H aas oscillation am plitude are produced together with m icrow ave-induced resistance oscillations, in agreem ent with experimental ndings. In addition, the suppression of the magnetoresistance caused by low-frequency radiation in the higher m agnetic eld side is also demonstrated.

PACS num bers: 73.50 Jt, 73.50 M x, 78.67.-n, 78.70.-g

I. IN TRODUCTION

The discovery of microwave induced magnetorersistance oscillations (MIMOs) and zero-resistance (ZRS) in high-mobility two-dim ensional states (EG)^{1,2,3,4} (2D) electron qas has stim ulated experim ental^{5,6,7,8,9,10,11,12,13,14} trem endous and theoretical^{15,16,17,18},19,20,21,22,23,24,25,26,27,28,29,30,31,32,33

interest in radiation related magneto-transport in 2D electron systems. Since theoretically it has been shown that the ZRS can be the result of the instability induced by absolute negative resistivity,¹⁹ the majority of microscopic models focus mainly on MIMOs in spatially uniform cases and identify the region where an negative dissipative magnetoresistance develops as that of measured zero resistance. Most of previous investigations concentrated on the range of low m agnetic elds $!_{c} = ! = 1$ ($!_{c}$ stands for the cyclotron frequency) subject to a radiation of frequency !=2100GHz, where M M Os show up strongly and Shubnikov-de Haas oscillations (SdHOs) are rarely appreciable. In spite of the fact that both MIMOs and SdHOs are magnetoresistance related phenomena appearing in overlapping eld regimes, little attention was paid to the in uence of a microwave radiation on SdHO until a recent experimental nding at higher frequency.¹¹ Further observations clearly show that the amplitudes of SdHOs are strongly a ected by m icrowave radiations of dierent frequency in both low $(!_{c}=! < 1)$ and high (! $_{c}$ =! > 1) m agnetic eld ranges.^{12,13,14} K ovalev et al.¹¹ observed a suppression of the SdHOs around cyclotron resonance ! ! induced by a radiation of 285 G H z. D u et al¹² found strong m odulations of SdH O in an ultra-clean 2D sam ple subjected to microwaves of 146GHz, clearly showing, in addition to the rst node at $!=!_{c}=1$, higher order nodes around $!=!_{c}=2$ and 3. M ani¹³ reported strong m odulation in the amplitude of SdHO s accompanying M IM O s and zero-resistance states

excited by a 163.5-G Hz radiation and large dropo of the dissipative resistivity below its dark value at high $(!_c=! > 1)$ eld side when subjected to low-frequency radiation. Very recently, Dorozhkin et al.¹⁴ reported both the strong suppression of the magnetoresistance caused by radiation below 30G Hz and an interesting modulation of SdHOs in the range $!_c=! > 1$. They found that SdHOs are generally strongly dam ped by the radiation but there is a narrow magnetic eld range in between allowed ranges of inter- and intra-Landau level transitions, where the amplitude of SdHO is insensitive to the microwave irradiation. These observations provide a more complicated and appealing picture of the microwave-related transport phenomena, which must be accounted for in any theoreticalm odel for M MOs.

W e propose that these SdHO m odulations com e from the electron heating induced by the microwave radiation. Under the illum ination of m icrow ave the electron system, which continuously absorbs energy from the radiation eld, would certainly be heated. Unfortunately, the electron heating has so far been ignored in most of the theoretical treatments. The electron-acoustic phonon interaction was previously considered to contribute to Landaulevel broadening²⁴ or to act as a dam ping³¹ for the orbit movement, providing a mechanism for the suppression of M IM Os when the lattice tem perature increases. Besides the inelastic electron-phonon scattering also plays another in portant role to dissipate energy from the electron system to the lattice. The energy absorption rate is indeed sm all in high-m obility electron systems at low tem perature as in the experim ents. This, how ever, does not imply a negligible electron heating, since the electron energy-dissipation rate is also sm all because of weak electron-phonon scattering at tem perature T 1 K.To dealwith SdHO, which is very sensitive to the sm earing of the electron distribution, one has to carefully calculate the electron heating due to m icrow ave irradiation in a uniform model.

On the other hand, m icrowave irradiation heats the

electrons and thus greatly strengthens the therm alizing trend of the system by enhancing the electron-electron scattering rate at this low temperature regime. This enables us to describe these high-m obility 2D electron systems with a quasi-equilibrium distribution in a moving reference frame.

In this paper we pursue a theoretical investigation on $M \ \mathbb{M} O s$ and SdHO s taking account of the electron heating under m icrow ave irradiation. We generalize the balance equation approach to radiation-induced magneto-transport in high m obility two-dimensional electron systems. By carefully calculating the electron heating based on the balance of the energy absorption from the radiation eld and the energy dissipation to the lattice through electron-phonon interactions in a typical G aA s-based heterosystem and taking into account the electrodynamic e ect, we are able not only to reproduce the interesting phenom ena of M $\mathbb{M} O s$ in quantitative agreement with experiments in amplitudes, phases and radiation dependence of the oscillation, but also to obtain SdHO m odulations observed in the experiments.

II. FORMULATION

A. Force- and energy-balance equations

This paper is concerned with the magnetotransport in a microscopically hom ogeneous 2D system, and refers the measured zero resistance to the macroscopic consequence of the instability due to the occurrence of negative dissipative resistivity.

W e consider N_e electrons in a unit area of an in nite quasi-2D system in the x-y plane with a con ning potentialV (z) in the z direction. These electrons, in addition to interacting with each other, are scattered by random in purities and/or disorders and by phonons in the lattice. W ithin the magnetic eld range relevant to M IM O phenom enon, the experim ents exclude the onset of the quantum H alle ect, thus allowing us to assume that the 2D electrons are in extended states.

To include possible elliptically polarized m icrowave illumination we assume that a dc electric eld E $_0$ and a high-frequency (HF) ac eld of angular frequency !,

$$E(t) = E_{s} \sin(!t) + E_{c} \cos(!t);$$
 (1)

are applied inside the 2D system in the x-y plane, together with a magnetic eld B = (0;0;B) along the z direction. The spatial hom ogeneity of the elds and the parabolic band structure allows to describe the transport of this system in terms of its center-of-mass (cm.) motion and the relative motion, i.e. the motion of electrons in the reference frame moving with the cm.^{34,35,36} The center-of-mass momentum and coordinate of the 2D electron system are de ned as P ____j p_{jk} and R N_e ¹ __j r_{jk} with p_{jk} (p_{jx}; p_{jy}) and r_{jk} (x_j; y_j) being the momentum and coordinate of the jth electron in the 2D plane, respectively, and the relative electron momentum and coordinate are de ned as $p_{jk}^{0} p_{jk} P = N_{e}$ and $r_{jk}^{0} r_{jk} R$, respectively. In terms of these variables, the H am iltonian of the system, H, can be written as the sum of a center-of-mass part H_{cm} and a relative electron part H_{er} (A (r) is the vector potential of the B eld),

$$H_{cm} = \frac{1}{2N_{e}m} (P - N_{e}eA (R))^{2} - N_{e}e(E_{0} + E(t)) - R(2)$$

$$H_{er} = \frac{X + h_{j}}{j} \frac{1}{2m} - p_{jk}^{0} - eA (r_{jk}^{0})^{2} + \frac{p_{jz}^{2}}{2m_{z}} + V (z_{j})^{1} + \frac{X}{k} - V_{c} (r_{ik}^{0} - r_{jk}^{0}; z_{i}; z_{j}); \quad (3)$$

together with electron-in purity and electron-phonon in-teractions

$$H_{ei} = \begin{array}{c} X \\ u(q_k; z_a) e^{iq_k (R + \frac{0}{j_k} r_{ak})}; \quad (4) \\ j_{i}^{a} q_k \end{array}$$

$$H_{ep} = \bigwedge_{j \neq q_{k}}^{X} (q_{k}; q_{z}) (b_{q} + b_{q}^{y}) e^{iq_{k}} (R + \frac{0}{j_{k}}):$$
(5)

Here m and m $_{\rm z}$ are, respectively, the electron e ective m ass parallel and perpendicular to the 2D plane, and V_c stands for the electron-electron C oulom b interaction; $u(q_k;z_a)$ is the potential of the ath impurity locating at $(r_{ak}; z_a); b_{\alpha}^{y}(b_{\alpha})$ are the creation (annihilation) operators of the bulk phonon with wavevector $q = (q_k; q_z)$ and M $(q_k;q_z)$ is the matrix element of the electronphonon interaction in the 3D plane-wave representation. Note that the uniform electric eld (dc and ac) appears only in $\rm H_{\,cm}$, and that $\rm H_{\,er}$ is just the Ham iltonian of a quasi-2D system subjected to a magnetic eld without an electric eld. The coupling between the centerofm ass and the relative electrons appears only in the exponential factor $\exp(iq_k - R)$ inside the 2D m om em tum q_k summation in H_{ei} and H_{ep}.³⁶ The balance equation treatm ent starts with the H eisenberg operator equation for the rate of change of the center-of-m ass velocity V_ = i[V;H]+ @V=@twith V = iR;H], and that for the rate of change of the relative electron energy $H_{er} = i[H_{er}; H]$. Then we proceed with the determ ination of their statistical averages.

As proposed in Ref.35, the cm. coordinate operator R and velocity operator V can be treated classically, i.e. as the time-dependent expectation values of cm. coordinate and velocity, R (t) and V (t), such that R (t) R (t⁰) = $\frac{R_t}{t^0}$ V (s)ds. We are concerned with the steady transport state under an irradiation of single frequency and focus on the photon-induced dc resistivity and the energy absorption of the HF eld. These quantities are directly related to the tim e-averaged and/orbase-frequency oscillating components of the cm. velocity. A lthough higher harm onics of the drift velocity through entering the damping force and energy exchange rates

in the resulting equations, in an ordinary sem iconductor the power of even the third harm onic current is rather weak as compared to the fundam ental current. For the HF eld intensity in the M IM O experiments, the electron of higher harm onic current is safely negligible. Hence, it su ces to assume that the cm. velocity, i.e. the electron drift velocity, consists of a dc part v_0 and a stationary tim e-dependent part v (t) of the form

$$V (t) = v_0 \quad v_1 \cos(!t) \quad v_2 \sin(!t):$$
 (6)

W ith this, the exponential factor in the operator equations can be expanded in term s of B essel functions $J_n(x)$,

$$\begin{array}{cccc} & R_{t} & & X^{i} \\ e^{i q_{k}} & t^{0} & V(s) ds & = & & J_{n}^{2} () e^{i (q_{k} & v & n!) (t & t^{0})} + \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ e^{i m (!t \ \prime)} & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & & & \\ & & & \\ & & &$$

Here the argum ent in the Bessel functions

$$\frac{1}{!} (q_k \ \underline{v})^2 + (q_k \ \underline{v})^2^{\frac{1}{2}};$$
 (7)

and $\tan' = (q_k \quad \underline{y}) = (q_k \quad \underline{y})$.

Under the in uence of a modest-strength HF electric eld the electron system is far from equilibrium. However, the distribution function of relative electrons, which experience no electric eld directly, may be close to an quasi-equilibrium type distribution function. For the experimental GaAs-based ultra-clean 2D electron system s having carrier m obility of the order of 2000 m 2 /V s, the elastic momentum scattering rate is around m^{\perp} 10 m K . In these system s, the therm alization tim e $_{\rm th}$ (i.e. the time for system to return to its internal equilibrating state when it is deviated from), estim ated conservatively using electron-electron (e-e) interaction related inelastic scattering time ee calculated with an equilibrium distribution function at tem perature T = 1K, is also around 1 th 1 ee 10 mK. The illum ination of microwave certainly heats the electrons. Even an electron heating comparable to a couple of degrees tem perature rise would greatly enhance e^{1} , such that the therm alization time the would become much shorter than the momentum relaxation time $_{\rm m}$ under m icrowave irradiation.³⁷ The relative electron system s subject to a m odest radiation would rapidly therm alize and can thus be described reasonably by a Ferm i-type distribution function at an average electron tem perature T_{e} in the reference fram e moving with the center-of-mass. This allows us to carry out the statistical average of the operator equations for the rates of changes of the cm. velocity V and relative electron energy H $_{\rm er}$ to the leading order in H $_{\rm ei}$ and H $_{\rm ep}$ with succinct form s.

For the determ ination of unknown parameter v_0 , v_1 , v_2 , and T_e , it su ces to know the damping force up to the base frequency oscillating term $F(t) = F_0 + F_s \sin(!t) + F_c \cos(!t)$, and the energy-related quantities up to the

tim e-average term s. We nally obtain the force and energy balance equations,

$$N_{e}eE_{0} + N_{e}e(v_{0} - B) + F_{0} = 0;$$
 (8)

$$v_1 = \frac{eE_s}{m!} + \frac{F_s}{N_em!} - \frac{e}{m!} (v_2 B);$$
 (9)

$$v_2 = \frac{eE_c}{m!} + \frac{F_c}{N_em!} - \frac{e}{m!} (v_1 B);$$
 (10)

$$N_{e}eE_{0} \quad \forall + S_{p} \quad W = 0:$$
 (11)

Here

is the tim e-averaged dam ping force,

$$S_{p} = \begin{bmatrix} X & & & X^{k} \\ & & & n! J_{n}^{2} & () _{2} (q_{k}; !_{0} & n!) \\ & & & & n = 1 \\ & & X & & \\ & & & M (q)^{2} & & n! J_{n}^{2} () _{2} (q; !_{0} + q & n!) (13) \\ & & & & q & & n = 1 \end{bmatrix}$$

is the time-averaged rate of the electron energy absorption from the HF eld, and

$$W = \int_{q}^{X} \int_{n=1}^{X} \int_{q}^{X} J_{n}^{2} ()_{2} (q;!_{0} + q n!)$$
(14)

is the time-averaged rate of the electron energy dissipation to the lattice due to electron-phonon scatterings. The oscillating frictional force amplitudes F_s F_{22} F_{11} and F_c $F_{21} + F_{12}$ are given by (= 1;2)

In these expressions, $q_k \quad v=! ; !_0$ $q_k \quad v; U (q_k)$ and M (q) are elective in purity and phonon scattering potentials (including elects of the spatial distribution of in purities and the form factor of quasi-2D electrons).³⁶ $_2(q_k;)$ and $_2(q;) =$ $2_2(q_k;) [n (q=T) n (=T_e)]$ (with n (x) $1=(e^x 1)$) are the in aginary parts of the electron density correlation function and electron-phonon correlation function in the presence of the magnetic eld. $_1(q_k;)$ and $_1(q;)$ are the real parts of these two correlation functions.

E ects of a m icrow ave radiation on electron transport rst com e from the HF eld induced cm.motion (electron drift m otion) and the related change of the electron distribution. In addition to this, the HF eld also enters via the argument of the Bessel functions in F_0, F , W and S_p . Compared with that without a HF eld, we see that in an electron gas having impurity and/or phonon scatterings (otherwise hom ogeneous), a HF eld of frequency ! opens additional channels for electron transition: an electron in a state can absorb or em it one or several photons of frequency ! and scattered to a di erent state with the help of impurities and/or phonons. The sum over jnj 1 represents contributions of real single and multiple photon participating processes. The role of these processes is two folds. On the one hand, they contribute additional dam ping force to the moving electrons, giving rise directly to photoresistance, and at the same time, transfer energy from the HF eld to the electron system, resulting in electron heating, i.e. another change (sm earing) in the electron distribution.³⁸ Furtherm ore, the radiation eld, showing up in the term with J_0 () in and W, gives rise to another e ective change of F₀, F dam ping forces and energy-loss rate, without em ission or absorption of real photons. This virtual photon process also contributes to photoresistance.³⁹ All these elects are carried by parameters v_0 , v_1 , v_2 and T_e . Eqs. (8)-(11) form a closed set of equations for the determ ination of these parameters when E_0 , E_c and E_s are given in a 2D system subjected to a magnetic eld B at temperature т.

B. Longitudinal and transverse resistivities

The nonlinear resistivity in the presence of a high-frequency eld is easily obtained from Eq.(8). Taking v_0 to be in the x direction, $v_0 = (v_{0x}; 0; 0)$, we immediately get the transverse and longitudinal resistivities,

$$R_{xy} \qquad \frac{E_{0y}}{N_{e}ev_{0x}} = \frac{B}{N_{e}e}; \qquad (17)$$

$$R_{xx} \qquad \frac{E_{0x}}{N_{e}ev_{0x}} = -\frac{F_{0}}{N_{e}^{2}e^{2}v_{0x}}:$$
(18)

The linearm agnetoresistivity is the weak dc current lim it (v_{0x} ! 0):

$$R_{xx} = \begin{pmatrix} X \\ q_{x} \end{pmatrix} \begin{pmatrix} \frac{1}{N} (q_{x}) \frac{2}{Y} & X^{k} \\ N_{e}^{2} e^{2} & n = 1 \end{pmatrix} J_{n}^{2} () \frac{\theta_{2}}{\theta_{2}} = n!$$

$$X \\ q_{x} \begin{pmatrix} \frac{1}{N} (q) \frac{2}{Y} & X^{k} \\ N_{e}^{2} e^{2} & n = 1 \end{pmatrix} J_{n}^{2} () \frac{\theta_{2}}{\theta_{2}} = q + n!$$
(19)

Note that although according to Eqs.(12), (18) and (19), the longitudinalm agnetoresistivity $R_{\,\rm xx}$ can be for-

m ally written as the sum of contributions from various individual scattering mechanisms, all the scattering mechanisms have to be taken into account simultaneously in solving the momentum – and energy-balance equations (9), (10) and (11) for v_1 , v_2 and T_e , which enter the Bessel functions and other parts in the expression of R_{xx} .

C. Landau-level broadening

In the present model the e ects of interparticle C oulom b screening are included in the electron complex density correlation function $(q_k;) = _1(q_k;) + i_2(q_k;)$, which, in the random phase approximation, can be expressed as

$$(q_{k};) = \frac{0}{(q_{k};)} (q_{k};)$$
 (20)

where

$$(q_k;) 1 V (q_k) _0 (q_k;)$$
 (21)

is the complex dynam ical dielectric function,

$$V(q_k) = \frac{e^2}{2_0 q_k} H(q_k)$$
 (22)

is the electric Coulomb potential with the dielectric constant of the material and H (q_k) is a 2D wavefunction-related overlapping integration,³⁶ $_0(q_k;) = _{01}(q_k;) + i _{02}(q_k;)$ is the complex density correlation function of the independent electron system in the presence of the magnetic eld. W ith this dynamically screened density correlation function the collective plasm a modes of the 2D E S are incorporated. D isregard these collective modes one can just use a static screening (q_k;0) instead.

The $_{02}$ (q_k;) function of a 2D system in a magnetic eld can be written in term s of Landau representation:³⁴

$${}_{02} (q_{k};) = \frac{1}{2} \frac{X}{\frac{1}{2}} C_{n;n^{0}} (l_{B}^{2} q_{k}^{2}=2) {}_{2} (n;n^{0};); (23)$$

$${}_{2} (n;n^{0};) = \frac{2}{-} \frac{X}{d''} [f ('') f ('' +)]$$

$$Im G_{n} ('' +) Im G_{n^{0}} (''); (24)$$

where $l_{B} = \frac{p}{1-jeB}$ j is the magnetic length,

$$C_{n;n+1}(Y) = n![(n+1)!]^{-1}Y^{1}e^{-Y}[L_{n}^{1}(Y)]^{2}$$
 (25)

with L_n^1 (Y) the associate Laguerre polynom ial, f (") = fexp[(")=T_e]+ 1g⁻¹ the Ferm i distribution function, and Im G_n (") is the imaginary part of the electron G reen's function, or the density of states (DOS), of the Landau level n. The real part function $_{01}$ (q_k;) and corresponding $_{01}$ (q_k;) function can be derived from their imaginary parts via the K ram ers-K ronig relation.

In principle, to obtain the G reen's function Im G_n ("), a self-consistent calculation has to be carried out from the D yson equation for the self-energy with all the in purity, phonon and e-e scatterings included. The resultant G_n is generally a complicated function of the magnetic eld, tem perature, and Landau-level index n, also dependent on the di erent kinds of scatterings. Such a calculation is beyond the scope of the present study. In this paper we m odel the DOS function with a Gaussian-type form ("n is the energy of the n-th Landau level):^{40,41}

$$\operatorname{Im} G_{n}(") = \frac{p \frac{1}{2}}{2} \exp^{h} \frac{2(" - "_{n})^{2} \dot{1}}{2}$$
(26)

with a broadening width given by

$$= \frac{8e!_{c}}{m_{0}}^{1=2}; \qquad (27)$$

where $_0$ is the linear mobility in the absence of the m agnetic eld and is a sem iem pirical parameter to take into account the di erence of the transport scattering time $_{\rm m}$ determining the mobility $_0$, from the single particle lifetime $_{\rm s}$ related to Landau level broadening. The latter depends on elastic scatterings of di erent types and their relative strengths, as well as contributions of electron-phonon and electron-electron scatterings. will be served as the only adjustable parameter in the present investigation. Unlike the sem ielliptic function, which can model only separated Landau-level case, a G aussian-type broadening function can reasonably cover both the separated-level and overlapping-level regim es.

D. E ect of radiative decay

The HF electric eld E (t) appearing in Eqs.(8) and (9) is the total (external and induced) eld really acting on the 2D electrons. Experiments are always performed under the condition of giving external radiation. In this paper we assume that the electrom agnetic wave is incident perpendicularly (along z-axis) upon 2D EG from the vacuum with the incident electric eld of

$$E_{i}(t) = E_{is} \sin(!t) + E_{ic} \cos(!t)$$
 (28)

at plane z = 0. The relation between E (t) and E_i(t) is easily obtained by solving the M axwell equations connecting both sides of the 2D EG which is carrying a sheet current density N_eev (t). If the 2D EG locates under the surface plane at z = 0 of a thick (treated as sem i-in nite) sem iconductor substrate having a refraction index n_s, we have^{42,43}

$$E (t) = \frac{N_{e}ev(t)}{(1 + n_{s})_{0}c} + \frac{2}{1 + n_{s}}E_{1}(t):$$
(29)

If the 2DEG is contained in a thin sample suspended in vacuum at the plane z = 0, then

$$E (t) = \frac{N_{e}ev(t)}{2_{0}c} + E_{i}(t):$$
(30)

In the numerical calculation of this paper we consider the latter case and use Eq. (30) for the total selfconsistent eld E (t) in Eqs. (9) and (10). This electrodynamic e ect,^{42,43} recently referred as radiative decay,²⁷ gives rise to an additional damping in the 2DEG response to a given incident HF eld. The induced damping turns out to be m uch stronger than the intrinsic damping due to scattering-related forces F_s and F_c for the experimental high-mobility systems at low temperatures. For alm ost all the cases pertinent to M IMO experiments we can neglect the forces F_s and F_c completely in solving v_1 (v_{1x} ; v_{1y}) and v_2 (v_{2x} ; v_{2y}) from Eqs.(9) and (10) for given incident elds E_{is} and E_{ic} , and obtain explicitly

$$v_{1x} = (a_{sx} + b_{sy}) = v_{1y} = (a_{sy} + b_{sx}) = v_{2x} = (a_{cx} + b_{cy}) = (31)$$

$$v_{2y} = (a_{cy} + b_{cx}) = (31)$$

with =
$$(1 \quad {}^{2}_{!} + {}^{2}_{!})^{2} + (2 \; {}^{2}_{!} \; {}^{2}_{!})^{2}$$
, and
sx = sx ! cy + ! cx

$$sy = sy + i cx + i cy cx = cx + i sy i sx cy = cy i sx + i sy (32)$$

Here

$$\frac{eE_{i}}{m!} \quad (= sx; sy; cx; cy); \quad (33)$$

! $!_c=!$ and ! =! with

$$=\frac{N_{e}e^{2}}{2m_{0}c}$$
 (34)

W ith these v_1 and v_2 , the argument entering the Bessel functions is obtained. All the transport quantities, such as S_p , W and R_{xx} , can be calculated directly with the electron temperature T_e determined from the energy balance equation (11).

III. NUMERICAL RESULTS FOR GAAS-BASED SYSTEMS

As in the experiments, we focus our attention on high mobility 2D EGs formed by GaAs/AlGaAs heterojunctions. For these systems at temperature T 1K, the dom inant contributions to the energy absorption S_p and photoresistivity R_{xx} R_{xx} (0) come from the inpurity-assisted photon-absorption and emission process. At di erent magnetic eld strength, this process is associated with electron transitions between either inter-Landau level states or intra-Landau-level states. A coording to (26), the width of each Landau level is about 2. The condition for inter-Landau level transition with impurity-assisted single-photon process⁴⁴ is !> !c 2, or !c=! < a_{inter} = (+ $\frac{2}{2} + 4$)²=4; and that for impurity-assisted intra-Landau level transition is !< 2,

or $!_c=! > a_{intra} = 2^{\circ}$, here $= (32e = m_0!)^{\frac{1}{2}}$. However, since the DOS of each Landau level is assumed to be Gaussian rather than a clear cuto function and the multi-photon processes also play roles, the transition boundaries between di erent regimes may be somewhat smeared.

As indicated by experiments,⁴⁵ although long range scattering due to remote donors always exists in the 2D heterostructures, in ultra-clean G aA s-based 2D sam ples having mobility of order of 10^3 m $^2/V$ s, the rem ote donor scattering is responsible for merely 10% or less of the total momentum scattering rate. The dom inant contribution to the momentum scattering rate comes from short-range scatterers such as residual in purities or defects in the background. Furtherm ore, even with the same momentum scattering rate the remote im purity scattering is much less e cient in contributing to m icrow ave-induced m agnetoresistance oscillations than short-ranged background in purities or defects.46 Therefore, in the num erical calculations in this paper we assum e that the elastic scatterings are due to short-range in purities random ly distributed throughout the GaAs region. The impurity densities are determined by the requirem ent that electron total linear m obility at zero magnetic eld equals the giving value at lattice tem perature T. Possibly, long-range rem ote donnor scattering m ay give rise to important contribution to the Landaulevel broadening. This e ect, together with the role of electron-phonon and electron-electron scatterings, is included in the sem iem pirical parameter in the expression (27).

In order to obtain the energy dissipation rate from the electron system to the lattice, W , we take into account scatterings from bulk longitudinal acoustic (LA) and transverse acoustic (TA) phonons (via the deform ation potential and piezoelectric couplings), as well as from longitudinal optical (LO) phonons (via the Frohlich coupling) in the GaAs-based system . The relevant matrix elements are well known.36 The material and coupling parameters for the system are taken to be widely accepted values in bulk GaAs: electron e ective mass $m = 0.068 m_e$ (m_e is the free electron m ass), transverse sound speed $v_{st} = 2.48 \quad 10^3 \text{ m/s}$, longitudinal sound speed $v_{sl} = 529 \quad 10^3 \text{ m/s}$, acoustic deform ation potential = 8:5 eV, piezoelectric constant $e_{14} = 1:41 \quad 10^9 \text{ V/m}$, dielectric constant = 12:9, m aterial m ass density d = $5:31 \, \text{g/m}^3$.

A. 100 GHz $\,$

Figure 1 shows the calculated energy absorption rate S_p , the electron temperature T_e and the longitudinal m agnetoresistivity R_{xx} as functions of $!_c=!$ for a 2D system having an electron density of $N_e = 3.0 \quad 10^{15} \text{ m}^{-2}$, a linear m oblity of $_0 = 2000 \text{ m}^2/\text{Vs}$ and a broadening parameter of = 10, subject to linearly x-direction polarized incident m icrow ave radiations of fre-

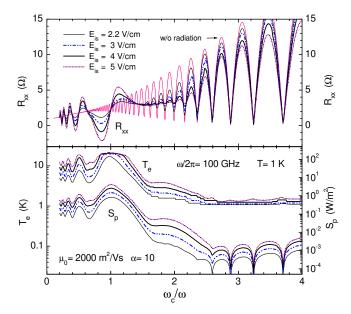


FIG. 1: The magnetoresistivity R_{xx}, electron temperature T_e and energy absorption rate S_p of a GaAs-based 2DEG with $_0 = 2000 \text{ m}^2/\text{V}\text{ s}$ and = 10, subjected to 100 GHz linearly x-polarized incident HF elds E is sin (!t) of four different strengths. The lattice temperature is T = 1 K.

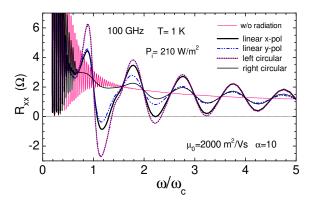


FIG.2: The m agnetoresistivity R_{xx} versus $!=!_c$ for the same system as described in Fig.1, subject to 100 G H z H F radiations of xed incident power of $P_i = 210 W / m^2$ but four di erent polarizations.

quency !=2 = 100 GHz having four di erent am plitudes $\text{E}_{is} = 2.2;3;4$ and 5 V/cm at a lattice temperature of T = 1 K. The energy absorption rate S_{p} exhibits a broad main peak at cyclotron resonance $!_{c}=! = 1$ and secondary peaks at harmonics $!_{c}=! = 1=2;1=3;1=4$. The electron heating has similar feature: T_{e} exhibits peaks around $!_{c}=! = 1;1=2;1=3;1=4$. For this G aAs system

= 0:65, a_{inter} = 1:6 and a_{intra} = 4:7. We can see that, at lowermagnetic elds, especially $!_c=! < 1:4$, the system absorbs enough energy from the radiation eld via inter-Landau level transitions and T_e is signi cantly higher than T, with the maximum as high as 21K around $!_c=! = 1$. W ith increasing strength of the magnetic eld the inter-Landau level transition weakens (in purity-assisted single-photon process is mainly allowed when

 $!_{c}=! < a_{inter} = 1.6$) and the absorbed energy decreases rapidly. W ithin the range $2 < !_c = ! < 4$ before intra-Landau level transitions can take place, $S_{\rm p}$ is two orders of m agnitude sm aller than that in the low m agnetic eld range. Correspondingly the electron tem perature T_e is only slightly higher than the lattice tem perature T . The magnetoresistivity R_{xx} showing in the upper part of Fig.1, exhibits interesting features. M IM Os (with xed points rather than extrem a at $!_{c}=! = 1; 1=2; 1=3; 1=4$) clearly appear at lower magnetic elds, which are insensitive to the electron heating even at T_e of order of 20K.SdHOs appearing in the higher magnetic eld side, however, are damped due to the rise of the electron tem perature $T_e > 1K$ as compared with that without radiation. With an increase in the microwave amplitude from $E_{is} = 22V/cm$ to 5V/cm, M IM O s become much stronger and SdHOs are further damped. But the radiation-induced SdHO dam ping is always relatively smaller within $2:4 < !_{c} = ! < 4$ between allowed ranges of inter-and intra-Landau level transitions.

It is worth noting that the predicted M IM O s here exhibit much improved agreement with experiments over previous theoretical models. The maxim a of R_{xx} oscillation locate at $!=!_c=j$ and minima at $!=!_c=j++$, with 0:23 0:25 for j=2;3;4::: and 0:16 0:18 for j=1 (see Fig.2). These phase details, as well as the absolute (rather than reduced) magnitudes of the oscillation amplitudes and the required incident microwave strengths to induce oscillations are in good quantitative agreement with experiments.^{3,4,5,6,7}

The MIMOs depend on the polarization of the incident m icrow ave eld in respect to the dc eld E_0 . Physically this is clear in the present model since it is through the c.m. motion that a HF eld a ects the photoresistivity of the 2D electron system. Under the in uence of a magnetic eld perpendicular to the plane, the cm.performs a cyclic motion of frequency $!_{\,\mathrm{c}}$ in the 2D plane. A perpendicularly incident circularly-polarized m icrow ave would accelerate or decelerate this cyclic motion depending on the HF electric eld circling with or against it. Thus, at x incident power, a left-polarized m icrowave would yield much stronger e ect on the R_{xx} oscillation than a right-polarized one and this e ect is apparently strongest in the vicinity of cylcotron resonance $!_{c}=!=1$. The di erence between the x-direction linearly polarized wave and the y-direction linearly polarized wave, how ever, com es mainly from the the dierent angle of radiation-induced c.m. motion with respect to the dc current, and thus not so sensitive to that of the $!_c=!$ range. In Fig.2 we plot the calculated R_{xx} versus !=! c for the same system as described in Fig.1, subject to a 100 G H z m icrow ave radiation having a xed incident power of $P_i = 210 \text{ W} / \text{m}^2$ (equivalent to an incident am plitude $E_{is} = 4V/cm$ of linear polarization) but four di erent polarizations: linear x-polarizaton, linear y-polarization, left circular polarization and right circular polarization. Their di erence is clearly seen.

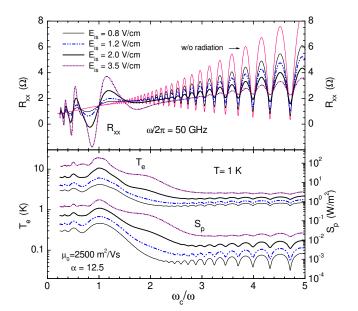


FIG. 3: The magnetoresistivity R_{xx} , electron temperature T_e and energy absorption rate S_p of a GaAs-based 2DEG with $_0 = 2500 \text{ m}^2/\text{V}\text{ s}$ and = 12.5, subjected to 50 GHz linearly x-polarized incident HF elds $E_{is} \sin (! t)$ of four different strengths. The lattice temperature is T = 1 K.

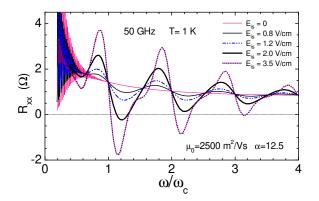


FIG.4: The m agnetoresistivity R_{xx} versus $!=!_c$ for the same system as described in Fig.3, subject to 50G Hz linearly x-polarized incident HF elds of four di erent strengths.

B. 50 GHz and lower frequency

Figure 3 shows the energy absorption rate S_p , the electron temperature T_e and the longitudinal magnetoresistivity R_{xx} as functions of $!_c=!$ for a 2D system having an electron density of $N_e = 3.0 \ 10^{15} \text{ m}^{-2}$, a linear mobility of $_0 = 2500 \text{ m}^2/\text{V}$ s and a broadening parameter of = 12:5, subject to linearly x-direction polarized incident m icrow ave radiations of frequency !=2 = 50 GHz having four di erent amplitudes $E_{is} = 0.8;12;2:0$ and 3.5 V/cm at a lattice temperature of T = 1 K. For this G aAs system at 50 GHz ainter = 1:9 and $a_{intra} = 2:4$. The intra-Landau level single-photon transitions are allowed when $!_c=! > 2:4$, yielding, at the high $!_c=!$ side, an absorption rate S_p som ewhat larger, an electron

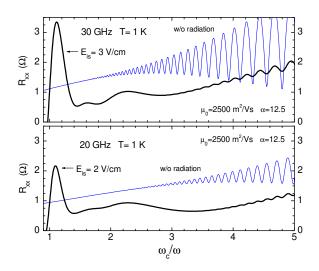


FIG.5: The m agnetoresistivity R_{xx} vs !_c=! for the same system as described in Fig.3, subject to two incident m icrowave elds: frequency !=2 = 30 G H z, am plitude E is = 3V/cm and frequency !=2 = 20 G H z, am plitude E is = 2V/cm.

tem perature T_e som ew hat higher, and a SdHO dam ping stronger than those in the 100-G H z case (Fig.1). On the other hand, at equivalent HF eld strength the multiphoton processes are more in portant at low er frequency. This helps to enhance the absorption S_p in the range 1:9 < $!_c$ =! < 2:4, where the single-photon process is forbidden and to increase the two-photon resonance in S_p and T_e around $!=!_c = 1.5;2.5$ and 3.5 (see S_p and T_e curves corresponding to E is = 3.5 V/cm in Fig.3). The e ect of the two-photon process can also be seen clearly in the R_{xx}-vs-!=!_c curves as shown in Fig.4, where the R_{xx} curve of E is = 3.5 V/cm exhibits obvious shoulders around !=!_c = 1.5;2.5 and 3.5, and the descends down around !=!_c = 0.6. This kind of two-photon process was clearly seen in the experiments.^{4,9}

At even lower frequency, such as $30\,\text{G}\,\text{Hz}$ and $20\,\text{G}\,\text{Hz}$, the ranges for intra-Landau level and inter-Landau level single-photon transitions overlap. The enhanced e ect of the virtual photon process, together with enhanced multiphoton-assisted electron transition, pushes the resistivity R_{xx} remarkably down below the average of its oscillatory curve without radiation, resulting in a strong suppression of dissipative magnetoresistance across a wide magnetic eld range as shown in Fig.5, in agreement with experimental observations.^{13,14}

C. 150 and 280 GHz

The radiation-induced SdHO modulation can be seen clearly in the low magnetic eld region $!=!_{c} > 1$ with higher radiation frequency. Figure 6 shows the calculated electron temperature T_{e} and magnetoresistivity R_{xx} as functions of $!=!_{c}$ for a 2D system of electron density $N_{e} = 3.0 \quad 10^{15} \text{ m}^{-2}$, linear mobility $_{0} = 2000 \text{ m}^{2}/\text{V} \text{ s}$ and = 3, subject to a 150-G H z m icrow ave radiation of

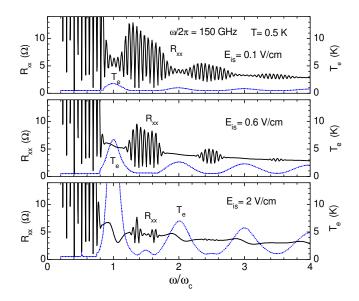


FIG.6: The magnetoresistivity R_{xx} and electron temperature T_e of a GaAs-based 2DEG with N_e = 3.0 10^{15} m 2 , $_0$ = 2000 m $^2/V$ s, and = 3, subjected to 150-GHz linearly x-polarized incident HF $\,$ elds E $_{is}$ sin (!t) of three di erent strengths E $_{is}$ = 0.1;0:6 and 2V/cm at T = 0:5K .

three di erent am plitudes $E_{is} = 0:1;0:6$ and 2V/cm at a lattice tem perature of T = 0.5 K. Low -power m icrow ave illum ination (E is = 0.1 V/cm) already yields su cient T e oscillation with maxima at $!=!_c = 1;2;3;4$, giving rise to clear SdHO modulations having nodes at Te maxima. At higher m icrowave power (E $_{is} = 0.6 V / cm$) when the M $\mathbb{I}M O$ shows up, the T_e maxim a gets higher, suppressing the SdHO in the vicinities of $!=!_{c}=1;2;3;4$, but a strong am plitude m odulation of SdHOs is still seen. In the case of $E_{is} = 2V/cm$, R_{xx} shows strong M IM O and the electron tem perature further grows so that most of SdHO s alm ost disappear in the range of $! = !_c > 2$. Note that the sm all T_e peaks at $! = !_c = 1.5$ and 2.5 are due to the absorption rate Sp maxim a induced by two-photon processes, which gives rise to additional nodes in the Sd-HOs.

Another example of the SdHO modulation appearing simultaneously with M IM O is plotted in Fig.7, where the energy absorption rate $S_{\rm p}$, the electron tem perature $T_{\rm e}$, and the magnetoresistivity R_{xx} are shown as functions of $! = !_{c}$ for a 2D system having an electron density of N_e = 3:0 10^{15} m², a linearm obility of $_0 = 1000$ m²/V s, and a broadening parameter of = 2, subject to linearly xdirection polarized incident m icrowave radiations of frequency !=2 = 280 GHz and am plitude $E_{is} = 3.5 \text{ V/cm}$. The energy absorption rate $S_{\rm p}$ has broad large peaks at $!=!_{c} = 1;2;3;4;5$ (due to single-photon resonant process) and small peaks at $!=!_c = 1:5;2:5$ (due to twophoton resonant process), giving rise to the oscillation of the electron tem perature $T_{\rm e}$. One can clearly see the peaks of the electron temperature $\ensuremath{\mathtt{T}}_{e}$ and the nodes of SdHO modulation at $!=!_{c} = 1;2;3;4$ and 5, together with M M Os. These are in agreement with the experi-

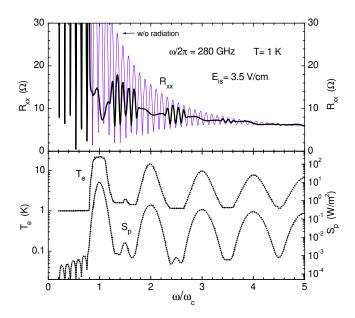


FIG. 7: The magnetoresistivity R_{xx} , electron temperature T_e and energy absorption rate S_p of a GaAs-based 2DEG with $_0 = 1000 \text{ m}^2/\text{V}\text{ s}$ and = 2, subjected to a linearly x-polarized incident HF eld of frequency 280GHz and am - plitude $E_{is} = 3.5 \text{ V/cm}$ at T = 1 K.

mental observation reported in Ref.11.

D. D iscussion

Note that in GaAs-based systems at a temperature around T 1K, LA phonons generally give larger con-

- ¹ M A.Zudov, R R.Du, JA.Simmons, and JL.Reno, Phys. Rev.B 64, 201311(R) (2001).
- ² PD. Ye, LW. Engel, DC. Tsui, JA. Simmons, JR. W endt, GA. Vawter, and JL. Reno, Appl. Phys. Lett. 79, 2193 (2001).
- ³ R.G. Mani, J.H. Smet, K. von K litzing, V. Narayanam urti, W.B. Johnson, and V. Umansky, Nature 420, 646 (2002).
- ⁴ M A.Zudov, R R.Du, L N.P fei er, and K W .W est, Phys. Rev.Lett. 90, 046807 (2003).
- ⁵ C L. Yang, M A. Zudov, T A. Knuuttila, R R. Du, L N. Pfei er, and K W. West, Phys. Rev. Lett. 91, 096803 (2003).
- ⁶ S.J.Dorozhkin, JETP Lett. 77, 577 (2003).
- ⁷ R.G. Mani, J.H. Sm et, K. von K litzing, V.N arayanam urti, W.B. Johnson, and V. Um ansky, Phys. Rev. Lett. 92, 146801 (2004).
- ⁸ R L. W illett, L N. P fei er, and K W. W est, Phys. Rev. Lett. 93, 026804 (2004).
- ⁹ M A.Zudov, Phys. Rev. B 69, 041304 (2004).
- ¹⁰ S.A. Studenikin, M. Potenski, A. Sachrajda, M. Hilke, L.N. Pfei er, and K.W. West, IEEE Tran. on nanotechnology, 4, 124 (2005);cond-m at/0411338.
- 11 A E . K ovalev, S A . Zvyagin, C R . B owers, J L . R eno, and

tribution to the electron energy dissipation W than that from TA phonons and LO phonons are usually frozen. However, in the case of high radiation power or in the vicinity of ! ! c, where the resonantly absorbed energy can be relatively large and the electron tem perature can rise up above 20K, a weak em ission of LO phonons takes place. Though at this tem perature the num ber of excited LO phonons is still very sm all and their contribution to momentum relaxation (resitivity) is negligible in comparison with acoustic phonons, they can already provide an e cient energy dissipation because each excited LO phonon contributes a huge energy transfer of 400K.W ith a continuing rise of electron tem -LO perature the LO -phonon contribution increases rapidly. This e ectively prevents the electron tem perature from going much higher than 20K, such that the T_e -vs-! $_c$ =! curve of large incident m icrow ave power in F ig.1 exhibits a at top around $!_{c} = ! = 1$.

In this paper, we did not consider the role of surface or interface phonons in the G aAs heterostructure. D epending on sample geometry, the surface phonons m ay be important in dissipating electron energy thus decreasing the electron tem perature.

A cknow ledgem ents

We thank Dr. V.I. Ryzhii, Dr. R.G. Mani and Dr. R.R. Du for helpful discussions. This work was supported by Projects of the National Science Foundation of China, the Special Funds for Major State Basic Research Project, and the Shanghai Municipal Commission of Science and Technology.

- JA.Simmons, Solid State Commun. 130, 379 (2004).
- ¹² R R.Du, M A.Zudov, C L.Yang, Z Q.Yuan, L N.P fei er, and K W.W est, Int. J.M od. Phys. B, 18, 3462 (2004).
- ¹³ R.G. Mani, Physica E 22, 1 (2004); Physica E 25, 189 (2004); Appl. Phys. Lett. 85, 4962 (2004).
- ¹⁴ S.I.D orozhkin, J.H. Sm et, V.Um ansky, K. von K litzing, cond-m at/0409228.
- ¹⁵ V J.Ryzhii, Sov.Phys.Solid State 11, 2087 (1970).
- ¹⁶ V J. Ryzhii, R A. Suris, and B S. Shcham khalova, Sov. Phys. Sem icond. 20, 1299 (1986).
- 17 P $\bar{\text{W}}$. And erson and W $\,\text{F}$. B rinkm an, cond-m at/0302129.
- ¹⁸ A A.Koulakov and M E.Raikh, Phys. Rev. B 68, 115324 (2003).
- ¹⁹ A.V. Andreev, IL. Aleiner, and A.J. Mills, Phys. Rev. Lett. 91, 056803 (2003).
- ²⁰ A.C.Durst, S.Sachdev, N.Read, and S.M.Girvin, Phys. Rev.Lett. 91, 086803 (2003).
- ²¹ J.Shiand X C.Xie, Phys. Rev. Lett. 91, 086801 (2003).
- ²² IA.Dm itriev, A D.M irlin, and D G.Polyakov, Phys.Rev. Lett. 91, 226802 (2003).
- ²³ X L.Leiand S.Y.Liu, Phys.Rev.Lett.91, 226805 (2003);
- ²⁴ X L.Lei, J.Phys.: Condens. M atter 16, 4045 (2004).
- ²⁵ V.Ryzhii and R.Suris, J.Phys.: Condens. Matter 15,

6855 (2003).

- ²⁶ M G. Vavilov and IL. A leiner, Phys. Rev. B 69, 035303 (2004).
- ²⁷ S.A.M ikhailov, Phys. Rev. B 70, 165311 (2004).
- ²⁸ J. D ietel, L. G lazm an, F. Hekking, F. von Oppen, Phys. Rev. B 71, 045329 (2005).
- ²⁹ M. Torres and A. Kunold, Phys. Rev. 71, 115313 (2005).
- ³⁰ IA.Dm itriev, M G.Vavilov, IL.A leiner, A D.M irlin, and D.G.Polyakov, Phys. Rev. B 71, 115316 (2005).
- ³¹ J. Inarrea and G. Platero, Phys. Rev. Lett. 94, 016806 (2005).
- $^{\rm 32}$ V.Ryzhii, cond-m at/0411370.
- ³³ C. Joas, J. Dietel, and F. von Oppen, cond-m at/0501397.
- ³⁴ C.S.Ting, S.C.Ying, and J.J.Quinn, Phys. Rev. B 14, 5394 (1977).
- ³⁵ X L.Leiand C S.Ting, Phys.Rev.B 32, 1112 (1985).
- ³⁶ X L. Lei, JL. B imm an, and C S. T ing, J. Appl. Phys. 58, 2270 (1985).
- 37 A spociated with the elastic collision term in the Boltzm ann equation for the distribution function is the momennum relaxation time or transport scattering time $_{\rm m}$, which indicates an ability to collect particles along a preference direction such as the electric eld or motion of cm., thus inclined to deviate the system from equilibrating distribution. The single particle lifetime $_{\rm s}$ related to elastic

scattering is the time that a quasiparticle can exist in a quantum state before it decays out. It represents an ability of spreading particles in all the directions thus towards an isotropic distribution along an equal-energy ring. The equilibrating distribution is isotropic in the cm . reference frame. The single particle lifetime $_{\rm s}$ would not induce any deviation from an equilibrating-type distribution.

- ³⁸ X L. Lei, J. Appl. Phys. 84, 1396 (1998); J. Phys.: Condens. M atter 10, 3201 (1998).
- ³⁹ X L.Leiand S.Y.Liu, Appl. Phys.Lett. 82, 3904 (2003)
- ⁴⁰ T.Ando, A.B. Fow ler, and F. Stem, Rev. M od. Phys. 54. 437 (1982).
- ⁴¹ M E. Raikh, T.V. Shahbazyan, Phys. Rev. B 47, 1522 (1993).
- ⁴² K W . Chiu, T K . Lee, and J.J. Quinn et al, Surf. Sci. 58, 182 (1976).
- ⁴³ S.Y. Liu and X.L. Lei, J. Phys.: Condens. M atter 15, 4411 (2003).
- ⁴⁴ Mulitiphoton (jnj> 1) processes of course can take place up to higher magnetic elds.
- ⁴⁵ V. Um ansky, R. de Picciotto, and Heiblum, Appl. Phys. Lett. 71, 683 (1997).
- ⁴⁶ X L.Lei, cond-m at/0409219.